Substitute for form 1449A/PTO		Complete if Known	
METORMATION DISCLOSURE	Application No.	10/570,907	
CTATEMENT DY ADDITION	Filing Date	March 6, 2006	
STATEMENT BY APPLICANT	First Named Inventor	Jae Chul Yong	•
( JAN 1 7 2007 )	Art Unit	2874	
	Examiner Name	Not yet known	_
Sheet Mapped of 1	Attorney Docket Number	24341-11349	

	U.S. PATENT DOCUMENTS						
		Document No.					
Examiner Initials*	Cite No.1	Number – Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document			

			FOREIGN PATENT I	OCUMENTS	
		Foreign Patent Document			
Examiner Initials*	Cite No.1	Country Code <sup>3</sup> – Number <sup>4</sup> Kind Code <sup>6</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	7⁰
		·			
		-	]		

	OTHER REFERENCES – NON-PATENT LITERATURE DOCUMENTS						
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposlum, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	т⁰				
QA.		KERSEY, A. D., et al., "Multiplexed Fiber Bragg Grating Strain-Sensor System with a Fiber Fabry-Perot Wavelength Filter," Optical Society of America, Optics Letters, Vol. 18, No. 16, pp. 1370-1372, August 15, 1993.					
$\alpha l$		YUN, S. H., et al., "Interrogation of Fiber Grating Sensor Arrays with a Wavelength-Swept Fiber Laser," Optical Society of America, Optics Letters, Vol. 23, No. 11, pp. 843-845, June 1, 1998.					
COH		PCT Written Opinion of the International Searching Authority, PCT/KR2004/002218, December 21, 2004.					

Examiner	1/1/1	Date	
Signature		Considered	$I/I/I \times I/I \longrightarrow I$
O Ignataro		00110100100	9/(//(0))
1			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609.

Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

'Applicant's unique citation designation number (optional). <sup>2</sup>See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.

## AP20 Rec's . CT/PTO 0 6 MAR 2006

	Substitute for	om 1449	VPTO	Complete if Known			
INFO	RMATION	N DIS	CLOSURE	U.S. Application No. PCT Application No.	Not Yet Assigned PCT/KR2004/002218 A T T T T T T T T T T T T T T T T T T		
			PLICANT	35 U.S.C. §371 Filing Date International Filing Date	March 6, 2006 September 2, 2004		
				First Named Inventor	Jae Chul Yong		
				Art Unit	Not Yet Known		
				Examiner Name	Not Yet Known		
Sheet	1	of	1	Attorney Docket Number	24341-11349		

U.S. PATENT DOCUMENTS						
<del>_</del>		Document No.	_			
Examiner Initials*	Cite No.1	Number – Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		
GA	A1	US-6,571,027 B2	05-27-2003	Cooper et al.		
	A2	US-6,449,047	09-10-2002	Bao et al.		
	A3	US-6,363,180	03-26-2002	Yamate et al.		
	A4	US-6,327,036	12-04-2001	Bao et al.		
	A5	US-6,204,920 B1	03-20-2001	Ellerbrock et al.		
	A6	US-6,097,487	08-01-2000	Kringlebotn et al.		
\\ \( \)	A7	US-6,024,488	02-15-2000	Wu et al.		

	FOREIGN PATENT DOCUMENTS								
		Foreign Patent Document							
Examiner Initials*	Cite No.1	Country Code <sup>3</sup> – Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	τ°				
UA	B1	KR 2002-0035967 A with English Abstract	05-16-2002	LEE, Ho Jun					
an	B2	KR 2001-0016729 with English Abstract	03-05-2001	Korea Advanced Institute of Science and Technology					
		-							

		OTHER REFERENCES - NON-PATENT LITERATURE DOCUMENTS	· · · · · · · · · · · · · · · · · · ·
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	™
QA.	C1	International Search Report (PCT/ISA/210) dated December 21,2004 for International Application No. PCT/KR2004/002218 (2 pages)	
1	İ		ļ
7			
	8		

		7			_	
Examiner Signature	941		Date Considered	4	$\int$	18/07

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809.

Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>&#</sup>x27;Applicant's unique citation designation number (optional). <sup>2</sup>See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the Indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.